


<b>Search Notes</b>  	<b>Application/Control No.</b>  10750502	<b>Applicant(s)/Patent Under Reexamination</b>  HILL ET AL.
	<b>Examiner</b>  Nguyen, Jennifer T	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	173-177,156,160,169	4/23/08	JN

SEARCH NOTES		
Search Notes	Date	Examiner
east, PG-Pub, IEEE, PJO, US-PAT, EPO, DERWENT, Inventors, Claim interference	4/23/08	JN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
178	18.01-18.20	4/23/08	JN